# <u>TOSHIBA</u>

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type ( $\pi$ -MOSII<sup>-5</sup>)

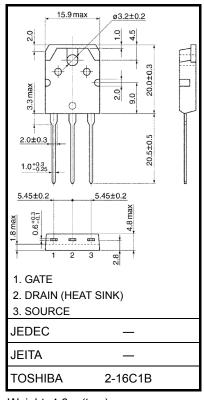
# 2SK1359

## DC-DC Converter and Motor Drive Applications

- Low drain-source ON resistance  $R_{DS}(ON) = 3.0 \Omega$  (typ.)
- High forward transfer admittance  $|Y_{fs}| = 2.0 \text{ S (typ.)}$
- Low leakage current  $: I_{DSS} = 300 \ \mu A \ (max) \ (V_{DS} = 800 \ V)$
- Enhancement mode :  $V_{th} = 1.5 \sim 3.5 \text{ V} (V_{DS} = 10 \text{ V}, \text{ ID} = 1 \text{ mA})$

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Characteristics		Symbol	Rating	Unit			
Drain-source voltage		V <sub>DSS</sub>	1000	V			
Drain-gate voltage (R <sub>GS</sub> = 20 kΩ)		V <sub>DGR</sub>	1000	V			
Gate-source voltage		V <sub>GSS</sub>	±30	V			
Drain current	DC (Note 1)	۱ <sub>D</sub>	5	А			
	Pulse (Note 1)	I <sub>DP</sub>	15	A			
Drain power dissipation (Tc = 25°C)		PD	125	W			
Channel temperature		T <sub>ch</sub>	150	°C			
Storage temperature range		T <sub>stg</sub>	-55~150	°C			

#### Absolute Maximum Ratings (Ta = 25°C)



Weight: 4.6 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

### **Thermal Characteristics**

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R <sub>th (ch−c)</sub>	1.0	°C / W
Thermal resistance, channel to ambient	R <sub>th (ch−a)</sub>	50	°C / W

Note 1: Ensure that the channel temperature does not exceed 150°C.

This transistor is an electrostatic-sensitive device. Please handle with caution. Unit: mm

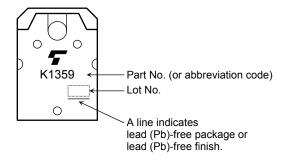
Electrical Characteristics (Ta = 25°C)

Charao	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	urrent	I <sub>GSS</sub>	I <sub>GSS</sub> V <sub>GS</sub> = ±25 V, V <sub>DS</sub> = 0 V		_	±50	nA
Drain cut-off cu	rrent	I <sub>DSS</sub>	V <sub>DS</sub> = 800 V, V <sub>GS</sub> = 0 V	—	_	300	μA
Drain-source br	reakdown voltage	V (BR) DSS	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V	1000		_	V
Gate threshold	voltage	V <sub>th</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	1.5		3.5	V
Drain-source O	N resistance	R <sub>DS (ON)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 2 A		3.0	3.8	Ω
Forward transfe	r admittance	Y <sub>fs</sub>	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 2 A		2.0	_	S
Input capacitance	ce	C <sub>iss</sub>			700	_	
Reverse transfe	erse transfer capacitance $C_{rss}$ $V_{DS}$ = 25 V, $V_{GS}$ = 0V, f = 1 MHz		_	55	_	pF	
Output capacitance		C <sub>oss</sub>		_	100	_	
Switching time	Rise time	tr	$V_{GS} \stackrel{10V}{}_{0V} \int_{C} \stackrel{I_{D}=2A}{}_{VOUT} \stackrel{VOUT}{}_{R_{L}} = 200\Omega$	_	18	_	- ns
	Turn-on time	t <sub>on</sub>		_	30	_	
	Fall time	t <sub>f</sub>		_	12	_	
	Turn-off time	t <sub>off</sub>	$V_{ ext{DD}} \rightleftharpoons 400  ext{V}$ Duty $\leq 1$ %, t $_{ ext{W}} = 10 \mu  ext{s}$	_	70	_	
Total gate charge (Gate-source plus gate-drain)		Qg		_	60	_	
Gate-source charge		Q <sub>gs</sub>	V <sub>DD</sub> ≈ 400 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4 A	—	35	—	nC
Gate-drain ("miller") charge		Q <sub>gd</sub>			25	—	

## Source–Drain Ratings and Characteristics (Ta = 25°C)

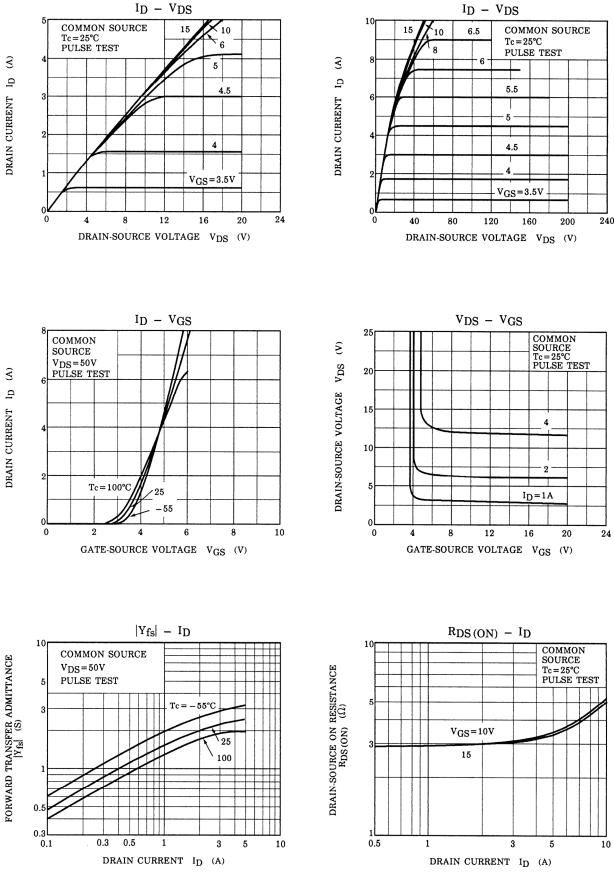
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I <sub>DR</sub>	_	_	_	5	А
Pulse drain reverse current (Note 1)	I <sub>DRP</sub>	_	_		15	А
Forward voltage (diode)	V <sub>DSF</sub>	I <sub>DR</sub> = 4 A, V <sub>GS</sub> = 0 V		_	-1.9	V

#### Marking

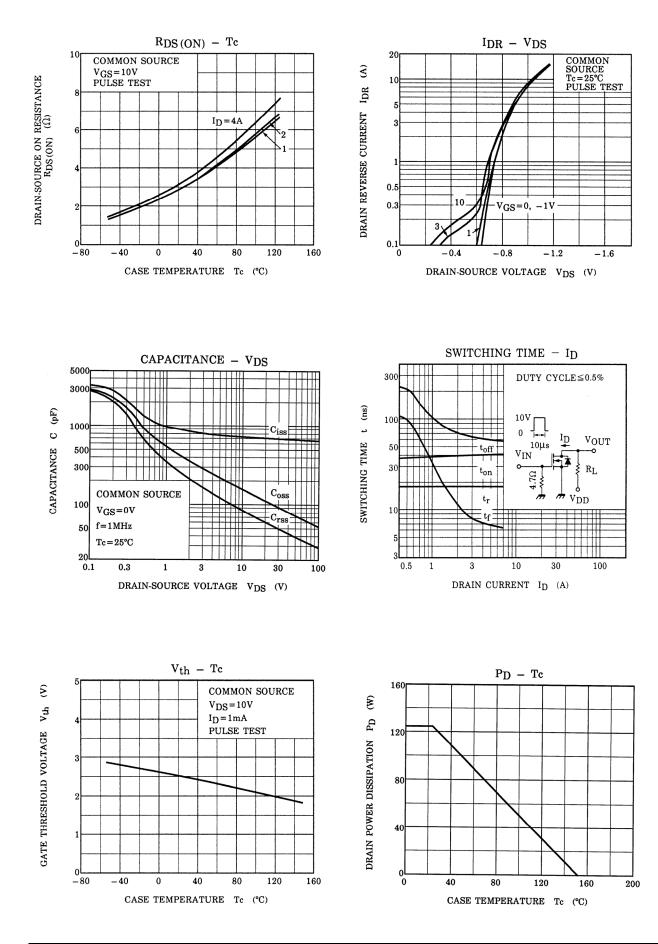


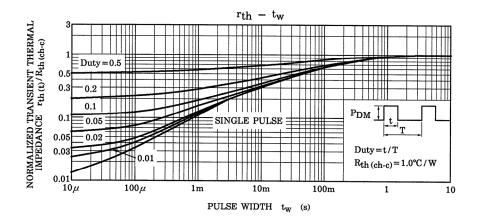
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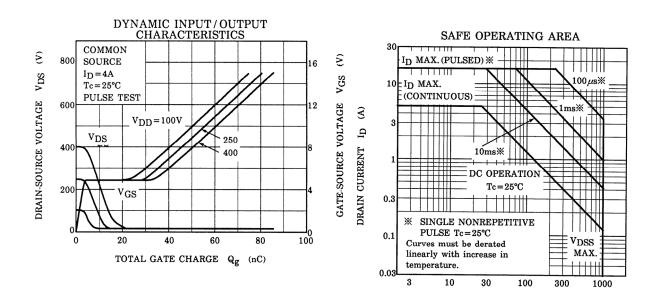
η DRAIN CURRENT



# **TOSHIBA**







DRAIN-SOURCE VOLTAGE VDS (V)

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